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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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|--|---|---------------------------|
| In re Application: Leblanc et al.  | ) | Group Art Unit: 1615      |
|  | ) |                           |
| Serial No. 10/813,153  | ) | Examiner: J. Venkat       |
|  | ) |                           |
| Filed: March 30, 2004  | ) | Atty. Docket No. 2022D.PC |
|  | ) |                           |
| For: Use of Solubilized, Anionic Polyurethanes in Skin Care Compositions |   |                           |

**INFORMATION DISCLOSURE STATEMENT**

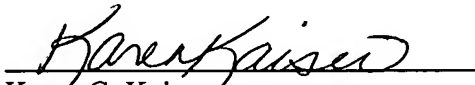
Commissioner for Patents  
Alexandria, VA 22313

Sir:

It is respectfully requested that the documents listed on the accompanying form PTO-1449 be considered and made of record. These documents were considered and made of record during the examination of parent application Serial No. 10/116,368. Copies of these documents may be found in the parent application. Applicants will submit additional copies of these documents upon the request of the examiner.

No fee is due as this paper is being filed within three months of the filing date.

Respectfully submitted,

  
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SHEET 1 OF 1

|  |    |  |          |                             |       |          |                            |    |
|--|----|--|----------|-----------------------------|-------|----------|----------------------------|----|
| Form PTO-1449<br>(REV. 7/80)   |    | U.S. Department of Commerce<br>Patent and Trademark Office |          | Atty. Docket No. 2022D.PC   |       |          | Serial No.<br>10/813,153   |    |
| <b>LIST OF REFERENCES CITED BY APPLICANT</b><br>(Use several sheets if necessary)  |    |  |          | Applicant: Leblanc et al.   |       |          |                            |    |
|  |    |  |          | Filing Date: March 30, 2004 |       |          | Group 1615                 |    |
|  |    |  |          |                             |       |          |                            |    |
| <b>U.S. PATENT DOCUMENTS</b>   |    |  |          |                             |       |          |                            |    |
| *Examiner Initial  |    | Document Number  | Date     | Name                        | Class | Subclass | Filing Date if Appropriate |    |
|  | AA | 5,478,562  | 12/26/95 | Caywet et al.               |       |          |                            |    |
|  | AB | 5,626,840  | 05/06/97 | Thomaides et al.            |       |          |                            |    |
|  | AC | 5,968,494  | 10/19/99 | Kukkala et al.              |       |          |                            |    |
|  | AD | 5,993,972  | 11/30/99 | Reich et al.                |       |          |                            |    |
|  | AE | 6,106,813  | 12/22/00 | Mondet et al.               |       |          |                            |    |
|  | AF | 6,238,654  | 05/29/01 | Tournilhac et al.           |       |          |                            |    |
|  | AG | 6,238,679  | 05/29/01 | De la Poterie               |       |          |                            |    |
|  | AH | 6,277,386  | 08/21/01 | Kim et al.                  |       |          |                            |    |
|  | AI | 6,291,580  | 09/18/01 | Kukkala et al.              |       |          |                            |    |
|  | AJ | 6,365,697  | 04/02/02 | Kim et al.                  |       |          |                            |    |
|  | AK | 2002/0155072   | 10/14/02 | Knuppel et al.              |       |          |                            |    |
| <b>FOREIGN PATENT DOCUMENTS</b>  |    |  |          |                             |       |          |                            |    |
|  |    | Document Number  | Date     | Country                     | Class | Subclass | Translation                |    |
|  |    |  |          |                             |       |          | Yes                        | No |
|  | AL | WO 94/03510 (English abstract only)                        | 02/17/94 | PCT                         |       |          |                            |    |
|  | AM | EP 0 656 021 (English claims only)                         | 07/17/93 | Europe                      |       |          |                            |    |
|  | AN | EP 0 925 774   | 06/30/99 | Europe                      |       |          |                            |    |
|  | AO | EP 0 937 451 (English abstract only)                       | 08/25/99 | Europe                      |       |          |                            |    |
|  | AP | EP 1 214 929   | 06/19/02 | Europe                      |       |          |                            |    |
|  | AR | JP 200114646 (English abstract only)                       |          | Japan                       |       |          |                            |    |
| <b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>   |    |  |          |                             |       |          |                            |    |
|  | AS |  |          |                             |       |          |                            |    |
| <b>EXAMINER</b>  |    |  |          | <b>DATE CONSIDERED</b>      |       |          |                            |    |
| <b>*EXAMINER:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |    |  |          |                             |       |          |                            |    |